

Datasheet

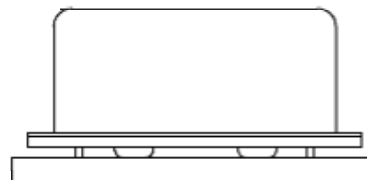
AXIOM125

OCXO IN SMD PACKAGE, SINE WAVE OUTPUT

FEATURES

- SMD holder size 22.7x15.1x11mm.
- SINE WAVE output
- Till +/-50ppb stability over temperature range
- Standard Frequencies 10 / 12.8 / 16.384 / 20.0 / 100 MHz

22.7 x 15.1 x 11 mm max.



Parameter	min.	typ.	max.	Unit	Condition
Frequency range	10		125	MHz	
Standard frequencies	10 / 12.8 / 16.384 / 20.0 / 100			MHz	
Frequency stability				ppm	
Initial tolerance		± 500		ppb	@+25°C, V _C = 2.5V
vs. temperature (steady state)			± 50	ppb	Option II = "50"
			± 100	ppb	Option II = "100"
			± 200	ppb	Option II = "200"
			± 300	ppb	Option II = "300"
			± 500	ppb	Option II = "500"
operating temperature range	-10		+60	°C	Note 2
vs. supply voltage variation			± 10	ppb	
vs. load change			± 20	ppb	
long term (aging) 1 st year (Note 3)			± 0.5	ppm	@ +40°C, after 30 days
Frequency adjustment range					
Electronic Frequency Control (EFC)	± 2		± 5	ppm	
EFC voltage V _C	0.15	1.65	3.15	V	Option I = "33"
	0.25	2.5	4.75	V	Option I = "50" or "12"
EFC slope (Df / DV _C)		positive			
EFC input impedance	100			kΩ	
RF output					
Signal waveform		Sinus			
Load		50		Ohm	
Output amplitude	+3			dBm	
Harmonic attenuation	20			dBc	
Warm-up time			2	min	Df _{final} /f ₀ < ±0.1 ppm
Supply voltage V_S	3.13	3.3	3.47	V	Option I = "33"
	4.75	5.0	5.25	V	Option I = "50"
	11.4	12.0	12.6	V	Option I = "12"
Current consumption (steady state)			300	mA	Option I = "33"
@ +25°C			200	mA	Option I = "50"
			90	mA	Option I = "12"
Current consumption (warm-up)			800	mA	Option I = "33"
			500	mA	Option I = "50"
			200	mA	Option I = "12"
Operable temperature range	-30		+75	°C	
Storage temperature range	-40		+85	°C	
Enclosure (see drawing) (LxWxH)	22.7x15.1x11 max.			mm	
Weight			5	gram	
ESD Sensitivity	1500			V	HBM as IEC 61000-4-2

Notes:

1. Terminology and test conditions are according to IEC standard IEC60679-1, unless otherwise stated
2. Other operating temperature range on request
3. Aging of ± 0.2 ppm / 1st year on request

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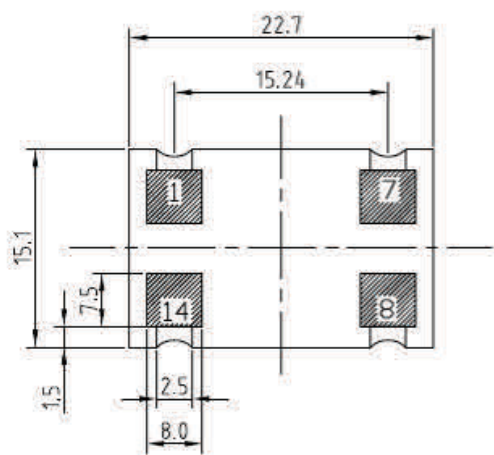
AXIOM125


OCXO IN SMD PACKAGE, SINE WAVE OUTPUT

Ordering Code:

Model (Specification)	Option I	Option II	Frequency [MHz]
AXIOM125	50	100	10.000

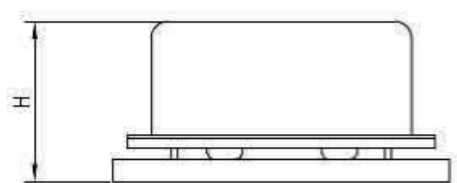
Enclosure drawing



 no pcbtrack beneath this area

Pin connections

Pin #	Symbol	Function
1	V _c	Voltage Control (EFC)
7	GND	Ground
8	RF OUT	RF Output
14	V _s	Supply Voltage



Environmental conditions

Test	IEC 60068 Part ...	IEC 60679-1 clause ...	Test conditions
Sealing tests (if applicable)	2-17	4.6.2	Gross leak: Test Qc, Fine leak: Test Qk
Solderability	2-20	4.6.3	Test Ta (235 ± 5)°C Method 1
Resistance to soldering heat	2-58		Test Tb Method 1A, 5s
Shock*	2-27	4.6.8	Test Ea, 3 x per axes 100g, 6 ms half-sine pulse
Vibration, sinusoidal*	2-6	4.6.7	Test Fc, 30 min per axes, 10 Hz - 55 Hz 0,75mm; 55 Hz - 2 kHz, 10g
Endurance tests			
- ageing		4.7.1	30 days @ 85°C, OCXO @25°C
- extended aging		4.7.2	1000h, 2000h, 8000h @85°C

Other environmental conditions on request